

<b>Notice of References Cited</b>	Application/Control No. 10/802,920	Applicant(s)/Patent Under Reexamination JEON ET AL.	
	Examiner Etsub D. Berhanu	Art Unit 3768	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,285,894	09-2001	Oppelt et al.	600/322
*	B	US-6,078,828	06-2000	Yasuda et al.	600/310
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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